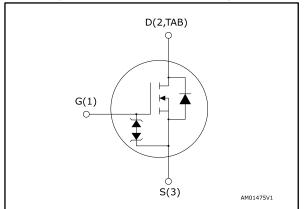


Datasheet - production data

Automotive N-channel 400 V, 0.058 Ω typ., 38 A MDmesh™ DM2 Power MOSFET in a TO-220 package

TAB TAB TO-220

Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D	Ρτοτ
STP45N40DM2AG	400 V	0.072 Ω	38 A	250 W

- Designed for automotive applications and AEC-Q101 qualified
- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

Switching applications

Description

This high voltage N-channel Power MOSFET is part of the MDmeshTM DM2 fast recovery diode series. It offers very low recovery charge (Q_{rr}) and time (t_{rr}) combined with low $R_{DS(on)}$, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Table 1: Device	summary
-----------------	---------

Order code	Marking	Package	Packing	
STP45N40DM2AG	45N40DM2	TO-220	Tube	

September 2015

DocID028082 Rev 2

This is information on a product in full production.

Contents

Contents

1	Electric	al ratings	3
2	Electric	al characteristics	4
	2.1	Electrical characteristics (curves)	6
3	Test cir	cuits	8
4	Packag	e information	9
	4.1	TO-220 type A package information	10
5	Revisio	n history	12



1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	±25	V
	Drain current (continuous) at T _{case} = 25 °C		٨
Ι _D	Drain current (continuous) at T _{case} = 100 °C		A
I _{DM} ⁽¹⁾	Drain current (pulsed)	152	А
P _{TOT}	Total dissipation at T _{case} = 25 °C	250	W
dv/dt ⁽²⁾	Peak diode recovery voltage slope	50	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	v/ns
T _{stg}	Storage temperature	55 to 150	°C
Tj	Operating junction temperature	-55 to 150	C

Notes:

 $^{\left(1\right) }$ Pulse width is limited by safe operating area.

 $^{(2)}$ I_{SD} \leq 38 A, di/dt=800 A/µs; V_{DS} peak < V_(BR)DSS, V_{DD} = 80% V(BR)DSS.

⁽³⁾ $V_{DS} \le 320 V$

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.50	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	62.5	C/VV

Table 4: Avalanche characteristics

Symbol	Parameter		Unit
I _{AR}	Avalanche current, repetitive or not repetitive	7	А
E _{AS} ⁽¹⁾	Single pulse avalanche energy	1100	mJ

Notes:

 $^{(1)}$ starting T_{j} = 25 °C, I_{D} = $I_{AR},\,V_{DD}$ = 50 V.



2 Electrical characteristics

(T_{case} = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	V_{GS} = 0 V, I_D = 1 mA	400			V
	Zoro goto voltogo droip	$V_{GS}=0~V,~V_{DS}=400~V$			10	
I _{DSS}	Zero gate voltage drain current	$\label{eq:VGS} \begin{array}{l} V_{\mathrm{GS}} = 0 \ V, \ V_{\mathrm{DS}} = 400 \ V, \\ T_{\mathrm{case}} = 125 \ ^{\circ}\mathrm{C} \end{array}$			100	μA
I _{GSS}	Gate-body leakage current	V_{DS} = 0 V, V_{GS} = ±25 V			±5	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 19 \text{ A}$		0.063	0.072	Ω

Table 6: Dynamic						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	2600	-	
C _{oss}	Output capacitance	V_{DS} = 100 V, f = 1 MHz, V_{GS} = 0 V	-	180	-	pF
C _{rss}	Reverse transfer capacitance		-	3.5	-	
C _{oss}	Equivalent output capacitance	$V_{DS} = 0$ to 320 V, $V_{GS} = 0$ V	-	300	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz, I _D = 0 A	-	4	-	Ω
Qg	Total gate charge		-	56	-	
Q _{gs}	Gate-source charge	V_{DD} = 320 V, I_D = 38 A, V_{GS} = 10 V (see Figure 15: "Test circuit for gate charge behavior")	-	13	-	nC
Q _{gd}	Gate-drain charge		-	28	-	

Notes:

 $^{(1)}$ $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% $V_{DSS}.$

		<u> </u>				
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	20	-	
tr	Rise time	$V_{DD} = 200 \text{ V}, I_D = 19 \text{ A } R_G = 4.7 \Omega,$ $V_{GS} = 10 \text{ V} (\text{see Figure 14: "Test circuit for resistive load switching times"})$	-	6.7	-	
t _{d(off)}	Turn-off delay time		-	68	-	ns
t _f	Fall time		-	9.8	-	

Table 7: Switching times

DocID028082 Rev 2	
-------------------	--



Electrical characteristics

	Table 8: Source-drain diode							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
I _{SD}	Source-drain current		-		38	А		
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		152	А		
V _{SD} ⁽²⁾	Forward on voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{SD} = 38 \text{ A}$	-		1.6	V		
t _{rr}	Reverse recovery time	I _{SD} = 39 A, di/dt = 100 A/μs, V _{DD} = 60 V (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	95		ns		
Q _{rr}	Reverse recovery charge		-	0.4		μC		
I _{RRM}	Reverse recovery current		-	8.5		A		
t _{rr}	Reverse recovery time		-	185		ns		
Q _{rr}	Reverse recovery charge	I_{SD} = 39 A, di/dt = 100 A/µs, V _{DD} = 60 V, T _j = 150 °C (see Figure 16: "Test circuit for inductive load switching and diode	-	1.62		μC		
I _{RRM}	Reverse recovery current	recovery times")	-	17.5		А		

Notes:

⁽¹⁾ Pulse width is limited by safe operating area.

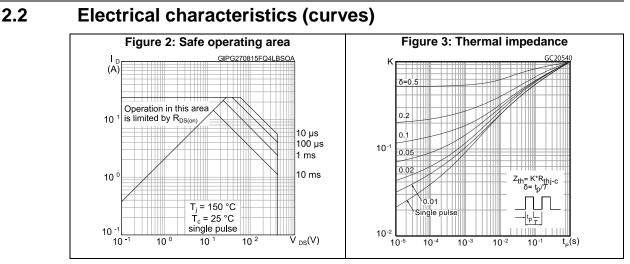
 $^{(2)}$ Pulse test: pulse duration = 300 $\mu s,$ duty cycle 1.5%.

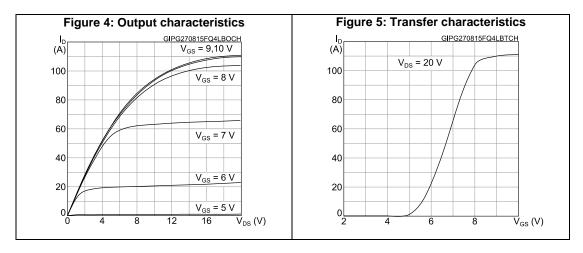
Table 9: Gate-source Zener diode

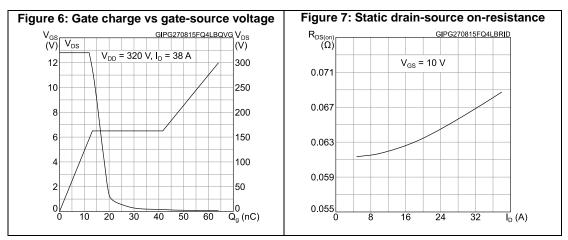
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)GSO}	Gate-source breakdown voltage	$I_{GS} = \pm 250 \ \mu A, I_D = 0 \ A$	±30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.







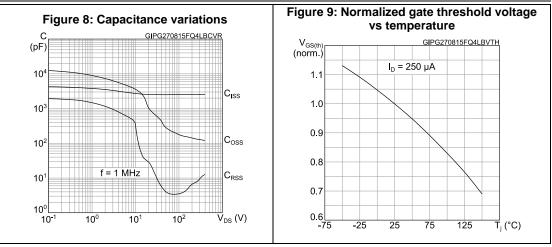


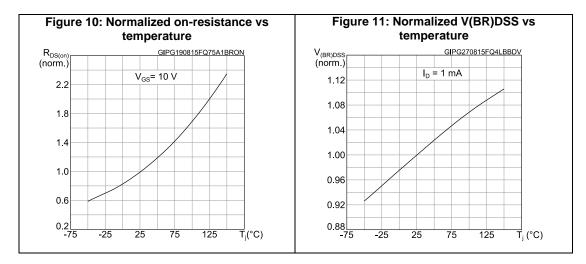
DocID028082 Rev 2

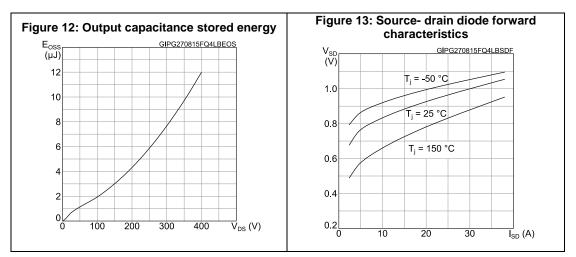


57

Electrical characteristics

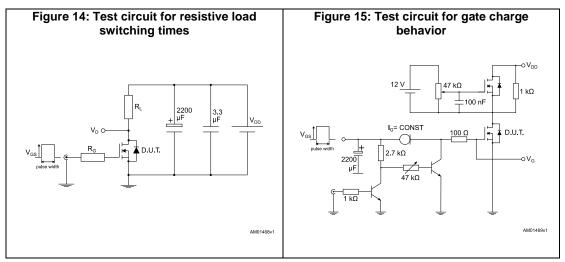


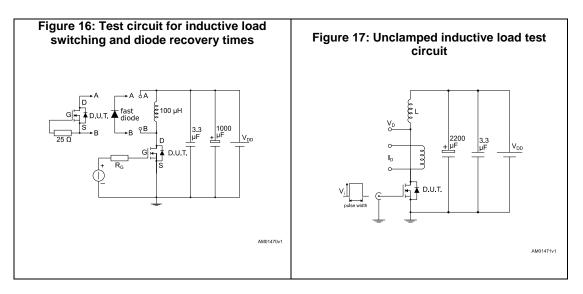


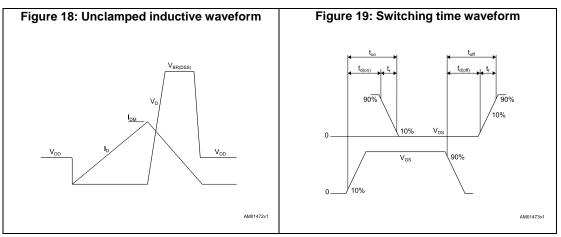


DocID028082 Rev 2

3 Test circuits







DocID028082 Rev 2

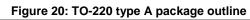


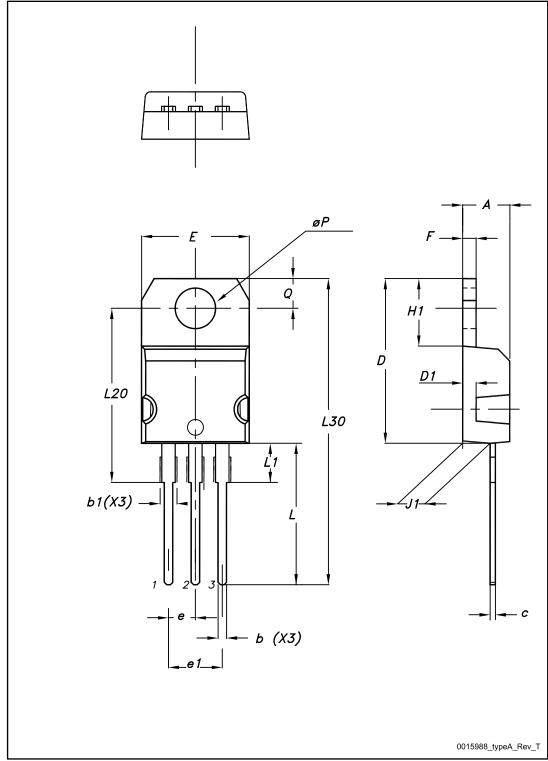
4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.











Package information

DMZAG			Package information				
Table 10: TO-220 type A mechanical data							
Dim	mm						
Dim.	Min.	Тур.	Max.				
A	4.40		4.60				
b	0.61		0.88				
b1	1.14		1.70				
С	0.48		0.70				
D	15.25		15.75				
D1		1.27					
E	10		10.40				
е	2.40		2.70				
e1	4.95		5.15				
F	1.23		1.32				
H1	6.20		6.60				
J1	2.40		2.72				
L	13		14				
L1	3.50		3.93				
L20		16.40					
L30		28.90					
øP	3.75		3.85				
Q	2.65		2.95				



5 Revision history

Table 11: Document revision history

Date	Revision	Changes
06-Jul-2015	1	First release.
03-Sep-2015	2	Datasheet promoted from preliminary data to production data Modified: I_D , I_{DM} , dv/dt values in table 2 Added: note 2 and 3 in table2 Modified: the entire values in table 4 Modified: $R_{DS(on)}$ typical value in table 5 Modified: the entire typical values in table 6 and 7 Modified: the entire typical values and I_{SD} , I_{SDM} in table 8 Added: Electrical characteristics (curves) section Minor text changes



IMPORTANT NOTICE – PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2015 STMicroelectronics - All rights reserved

